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# Characterization of Cobalt Selenide Films using FESEM and EDX

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**Abstract:** Preparation of thin films via chemical and physical deposition technique had been reported by many researchers. The obtained films were characterized by using various tools. Thin films were used in different applications including solar cell, light emitting diode, capacitor, photo detector, ultra violet opto-electronics, and photonic integrated circuit. In this work, the successive ionic layer adsorption and reaction (SILAR) method was used because of low temperature deposition, the simplest and the cheapest deposition method. This is the first time, composition of thin films (under various deposition cycles) was studied using energy dispersive x-ray analysis (EDX). EDX results confirmed that the atomic percentage of cobalt and selenide strongly depended on the number of deposition cycle in the experiment. Larger grain size could be observed for the thin films deposited for 20 cycles based on the field emission scanning electron microscopy analysis. **Keywords:** Thin film, SILAR deposition, morphology, cobalt selenide, solar cell, semiconductor.

### **1** Introduction

Synthesis and characterization of thin films have been reported by many researchers [1-3]. Physical and chemical deposition techniques [4-6] were used to produce binary, ternary, quaternary and pen ternary films. The obtained thin films were characterized by using various tools to investigate the properties of films. For example, structure, electrical, composition, morphology, topography and optical properties were investigated via X-ray diffraction [7], energy dispersive x-ray analysis, scanning electron microscopy, atomic force microscopy [8], UV-visible spectrophotometer [9], Raman spectroscopy, X-ray photoelectron spectroscopy [10], and Fourier transform infrared spectroscopy [11].

In this work, cobalt selenide thin films were deposited onto glass substrate by using successive ionic layer adsorption and reaction under different deposition cycles. Characterization of thin films was carried out via energy dispersive x-ray analysis, and field emission scanning electron microscopy (to study the composition and morphology of samples).

## **2** Experimental Details

2.1 Preparation of Thin Films

Several chemicals such as cobalt (II) chloride hexahydrate (CoCl<sub>2</sub>.6H<sub>2</sub>O) and sodium selenite (Na<sub>2</sub>O<sub>3</sub>Se) were employed (without further purification) for the production of films. The microscope glass slide was selected (substrate) in this work. The glass slide was cleaned by acetone, and deionized water before use. During the synthesis of films, the glass slide immersed in the 0.25 M cationic solution (Co<sup>2+</sup> ion) for 25 seconds. After rinsing with de-ionized water for 7 seconds, it was immersed in 0.25 M anionic solution (Se<sup>2-</sup> ions) for 25 seconds. Then, rinsing with de-ionized water for 7 seconds (to remove the loose material on sample). The pH of reaction solutions was pH=2.3. The sodium hydroxide (NaOH) and hydrochloric acid (HCl) solution were used to adjust the pH value. The films were collected after completed deposition process (10, 15 and 20 cycles), rinsed by de-ionized water, and lastly, place in the oven for 24 hours.

#### 2.2 Characterization of Thin Films

The surface morphologies of the films were investigated by using field emission scanning electron microscope (FEI, Nova Nanosem 230). The presence of different elements in obtained films could be determined by using energy dispersive analysis of the X-ray (EDX) analyzer.

## **3** Results and Discussions



Generally, thin film deposition methods could be grouped into two categories such as physical technique and chemical method. The successive ionic layer adsorption and reaction (SILAR) method was used for deposition of films. This deposition technique possesses many advantages [12] and can produce film thicknesses in the range of tenths of nanometers to several micrometers [13]. This method consisted of two parts including adsorption of ion onto the substrate and reaction of the adsorbed ion layer will be observed [14]. There are many tools such as AFM, XRD, EDX, SEM, XPS, TEM, STM, UV-visible

spectrophotometry, FTIR spectroscopy, and Raman spectroscopy have been used for the characterization of obtained films. Scanning electron microscopy (SEM) and energy dispersive X-ray (EDX) analysis of binary (Table 1), ternary (Table 2) and quaternary thin films (Table 3) were reported by many researchers.

Table 1: Scanning electron microscopy and energy dispersive X-ray analysis of binary thin films.

Thin films	EDX and SEM/FESEM results
ZnSe	EDX: Atomic ratio of Se:Zn =47.88: 46.58
	SEM: flower like morphology [15]
7.5	EDV: Atomic setio of $7 \times 8 = -40.44$ , 50.55
ZnSe	EDA: Atomic ratio of Zn:Se =49.44: 50.55
	SEMI: Crystallite sizes (100-300 nm) thickly packed together [16]
SnSe	EDX: Atomic ratio of Sn:Se =49.7: 50.3
	SEM: uniform distribution of grain size, compact and fined grained [17]
<b>5</b> # <b>5</b> 2	EDV. Atomic actic of Sp. So -48 8, 51 2
51150	EDA: Atomic ratio of Sil.Se -46.6: 51.2 SEM: grain size in algorated direction film thiskness was 10 um [19]
	SEM: grain size in elongated direction, film thickness was 10 µm [18]
SnSe	EDX: Atomic ratio of Sn:Se =49.93: 50.07
	SEM: worm-like grains, grains distributed uniformly could be observed [19]
SnS	EDX: Molar ratio of Sn:S =1:0.96
	SEM: grain sizes about 0.2 to 0.5 $\mu$ m [20]
Cu <sub>2</sub> S	EDX: Average atomic ratio of copper:sulfur was 1.89, 1.95 & 2.25 for the films prepared at
	55, 65 & 75 °C, respectively.
	SEM: smaller grain size was observed for the films deposited at lower bath deposition
	temperature [21]
CuS	EDX: Atomic percentage of Cu:S was 56.87:43.13 for the films deposited at 20 minutes.
	SEM: Grain size increased with increasing deposition time from 5 to 20 minutes [22].
CdS	EDX: Atomic percentage of cadmium:sulfur was 53.12: 46.88.
	SEM: Spherical shaped, small grain, homogeneous morphology [23]
CdS	EDX: The obtained films indicated good stoichiometry
0.00	SEM: The surface is smooth, uniformly covered with nano particles [24].
CdSe	EDX: Atomic percentage of selenium:cadmium is 76.44: 23.56 for the films prepared at room
	temperature [25].
	Atomic percentage of selenium: cadmium is 15.47: 84.53 for the films synthesized at 100 °C.
	SEM: Grains were polycrystalline and covered entire surface of substrate.
CdTe	EDX: Results indicated Cd-Te ratio is almost stoichiometric [26].
	SEM: big grain size, low porosity and uniform coverage in as-deposited films.
CdTe	EDX: The films prepared at cathodic voltage less than 1360 mV showed Te-richness.
	The films produced at 1360 mV indicated cadmium richness $[27]$ .
	SEM: Aggiomeration of small crystallites, cauliflower-like shaped in as-deposited films.
1	

Thin films	EDX and SEM results	
CuInS <sub>2</sub>	EDX: The atomic percentage of copper, indium and sulfur was 35.62:21.6:42.78 when [Cu]/[In]=1.2. SEM: The porous and dense morphology for the films prepared using [Cu]/[In]=0.8, and [Cu]/[In]=1.2, respectively [28].	
CuInS <sub>2</sub>	EDX: atomic percentage of copper:indium:Sulphur was 22%:28%:50% SEM: Film thickness and grain size were 350 nm and 500 nm, for the films prepared using lowest concentration of precursors [29].	
CuInSe <sub>2</sub>	EDX: Cu/In ratio (0.43 to 1.2) and Se/[Cu+In] ratio (0.92 to 1.47) were studied [30]. SEM: The films exhibited big and densely packed crystal morphologies (size= 5 $\mu$ m)	
CuinSe <sub>2</sub>	<ul> <li>EDX: The films consisted of same amount of indium and selenium. However, samples contained more copper when the films were produced at higher temperature and longer deposition time [31].</li> <li>SEM: the films showed dendritic structure, not-well defined grains, agglomerated and film thickness (90 μm).</li> </ul>	
CuInSe <sub>2</sub>	EDX: The films exhibited high selenium content [32]. SEM: Rough surface morphologies, indicating reaction process has not been fully completed for the films prepared at 300 °C.	
CuInSe <sub>2</sub>	EDX: The ratio of copper, indium and selenium about 1:1:2. SEM: Grain size (100 nm) was observed for the films prepared at 400 °C for 1 hour [33].	
CuInSe <sub>2</sub>	EDX: The films showed poor in copper and rich in indium [34]. SEM: Different morphologies could be observed for the films prepared at 550 °C (dense, compact) and 650 °C (laminar morphology with various shapes).	
CuInSe <sub>2</sub>	EDX: Analysis results showed face-to-face annealing providing stoichiometry ratio of (Cu+In)/Se about 1. SEM: Bigger grain size (3 μm) could be observed [35] by applying larger weights (5.2 kg).	
CuInTe <sub>2</sub>	EDX: The films prepared at -0.5 V, -0.6 V, -0.7 V and -0.8 V showed stoichiometry ratio near to CuInTe <sub>2</sub> . SEM: Polycrystalline was observed [36].	

**Table 2:** Scanning electron microscopy and energy dispersive X-ray analysis of ternary thin films.

Table 3: Scanning electron microscopy and energy dispersive X-ray analysis of quaternary thin films

Thin films	EDX and SEM results		
Cu <sub>2</sub> ZnSnS <sub>4</sub>	EDX: Zn/Sn values are 0.68%, 0.69%, 0.7% and 0.71% for the films prepared at 1.1V, 1.2V, 1.3V and 1.4 V, respectively. SEM: Uniform thickness [37] without tiny holes could be observed for the films deposited at 1.4 V.		
Cu <sub>2</sub> ZnSnS <sub>4</sub>	EDX: The presence of copper, zinc, sulfur and tin in sample could be detected [38]. SEM: larger grains could be seen in high temperature treatment films.		
Cu <sub>2</sub> ZnSnS <sub>4</sub>	EDX: The film prepared at 450 °C, 60 minutes, indicated Zn/Sn, Cu/[Zn+Sn] and S/metal ratio were 0.87, 1.48 and 0.8, respectively [39]. SEM: Uniform, dense without voids could be seen in samples.		



$Cu_2ZnSnS_4$	EDX: Atomic percentage values of copper: zinc: tin: sulphur were in the range 22.82 to 29.51: 19.88 to 28.82: 9.62 to 12.81: 37.8 to 38.74 for the films prepared onto soda lime		
	glass [40].		
	EDX: Atomic percentage values of copper: zinc: tin: sulphur were in the range 25.58 to		
	30.51: 18.61 to 28.52: 11.26 to 12.73: 34.64 to 39.42 for the films prepared onto ITO glass.		
	SEM: The most homogeneous surface was observed in ITO substrate.		
	Inhomogeneous grains with porosity could be seen in soda lime glass.		
$Cu_2ZnSnS_4$	EDX: Atomic percentage of copper: zinc: tin: Sulphur was 22.95: 11.38: 12.51: 53.16 in the obtained sample [41].		
	SEM: Smooth, compact and uniform morphology with size $(1 \ \mu m)$ was observed for the		
	films prepared at 580 °C.		
Cu <sub>2</sub> ZnSnS <sub>4</sub>	EDX: Copper richcomposition, zinc and tin loss in annealed sample under flow rate of gas		
	more than 60 sccm [42].		
	SEM: The films showed dense and polycrystalline structure		
$Cu_2ZnSnS_4$	EDX: Copper poor and zinc rich composition were observed for the films prepared at		
	deposition potential from -0.85 V to -1.05 V		
	SEM: Formation of interconnected grains, and an increase in grain size could be seen [43]		
$Cu_2ZnSnS_4$	EDX: the atomic percentage of copper:zinc: tin: Sulphur was 36.64:16.26:23.11:25.99.		
	SEM: The obtained samples showed uniform size (less than 100 nm), smooth and		
	homogeneous [44].		
$Cu_2ZnSnS_4$	EDX: As-deposited films indicated composition close to stoichiometric. The loss of tin		
	could be observed in annealed samples [45].		
	SEM: Lateral grain and columnar in shape could be seen in as-deposited films and annealed		
	samples.		

The energy dispersive X-ray (EDX) analysis is used in different research areas such as biomedical fields, environmental pollution, engineering and material science. It is very useful tool to study nanoparticles, to investigate heavy metals pollutions, to determine the composition of samples, and showed high sensitivity in detecting the various elements in tissues [46]. Generally, it is a technique of elemental analysis associated to electron microscopy based on the generation of characteristic X-rays that reveals the presence of elements present in the samples [47]. The scanning electron microscopy (SEM) was used in various types of science and industry applications. This is due to SEM produced high resolution, sharp, black and white images [48]. Several advantages were highlighted by researcher such as easy to operate, samples required minimal preparation actions, and it works fast [49]. Basically, SEM can focused electron beam over a surface to create picture. The electrons in the beam interact with the sample, forming different signals, could be employed to obtain information (surface topography and composition). Table 4 showed some limitations of transmission electron microscopy (TEM), atomic force microscopy (AFM) and scanning tunneling microscope (STM).

Table 4: Limitation of TEM, AFM and STM.

Transmission Electron Microscopy (TEM)	atomic force microscopy (AFM)	scanning tunneling microscope (STM)
It is very large [50]and very expensive	Maximum scanning area is 150 x150 μm [52]	It is very expensive and could be very difficult to use effectively [54]
It required special housing [51] and maintenance	Image a maximum height on the order of 10-20 µm [53]	Required a lot of skill to operate it [55]

The compositional analysis of the obtained films was studied by using the energy dispersive analysis (EDX) of the X-ray technique. The EDX spectrum of the cobalt selenide thin films deposited under 10 cycles as shown in figure 1a. The quantitative elemental analysis was done only for the selenium and cobalt. The atomic percentage (%) for cobalt and selenium was 53.52 % and 46.48%, respectively. When the films deposited for 15 cycles, the atomic percentage for selenium and cobalt was 72.99% and 27.01% respectively (figure 1b). Lastly, the films prepared deposited under 20 cycles (figure 1c) showed the atomic percentage for cobalt and selenium was 39.73% and 60.27%. From the EDX analysis studies, the amount of cobalt and selenium strongly depended on the number of deposition cycle during the experiment. Veeradasan and co-workers [56] reported that EDX spectra of the zinc oxide films with different Au thicknesses. Hend and co-workers [57] highlighted that the presence of zinc and oxygen with a pure phase in obtained samples based on EDX spectra.





[a]



[b]



[c]

**Fig.2:** FESEM images for the cobalt selenide films deposited under [a] 10 cycles [b] 15 cycles [c] 20 cycles.

The films prepared using 10 (figure 2a) and 15 (figure 2b) deposition cycles indicated smaller grain size (0.5 to 1  $\mu$ m). FESEM images exhibited inhomogeneous morphology and the grains partially covered the surface of the substrate. Researchers pointed out that large pinhole sizes caused poor device performance [58] in solar cell applications. This is because of a large number of trap assisted recombination centers of trapping and lower carrier mobilities [59]. On the other hand, the films deposited under 20 deposition cycles (figure 2c) showed bigger grain (1-2  $\mu$ m). FESEM analysis confirmed that the grains covered entire surface of substrate. Scientists concluded that bigger grain will



improve the performance of the solar cell [60], because of the charge carriers encounter fewer trapping [61] and scattering sources [62].

## **4** Conclusions

The cobalt selenide thin films were produced onto soda lime glass via SILAR method under various deposition cycles. The morphology and composition of obtained films were studied by using FESEM and EDX. Experimental findings highlighted that deposition cycles played an important role in the formation of the films as indicated in the EDX spectra. FESEM showed that the grain size increases as the SILAR deposition cycle was increased from 10 to 20 cycles.

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